

**Search Notes**

Application/Control No.

10/517,517

Examiner

Seung H. Lee

Applicant(s)/Patent under  
Reexamination

DEMMELE ET AL.

Art Unit

2887

**SEARCHED**

| Class | Subclass | Date      | Examiner |
|-------|----------|-----------|----------|
| 235   | 379      | 1/18/2008 | SL       |
| 235   | 380      | 1/18/2008 | SL       |
| 705   | 45       | 1/18/2008 | SL       |
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**INTERFERENCE SEARCHED**

| Class   | Subclass | Date      | Examiner |
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| Same as | Above    | 1/18/2008 | SL       |
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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|           | DATE      | EXMR |
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| EAST      | 1/18/2008 | SL   |
| PCT cites | 1/18/2008 | SL   |
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